SHARP

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To ;

SPECIFICATIONS

Product Type 8M bit PSRAM (524,288×16bit)

LH6P82Z1

Model No. (LH6P82Z1)

※This specifications contains 26 Pages including the cover and appendix.
If you have any objections, please contact us before issuing purchasing order.

CUSTOMERS ACCEPTANCE

DATE:

BY:

PRESENTED

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SHARP CORPORATION

SHARP

LH6P82Z1

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●When using the products covered herein, please observe the conditions written herein and the precautions outlined in the following paragraphs. In no event shall the company be liable for any damages resulting from failure to strictly adhere to these conditions and precautions.

(1) The products covered herein are designed and manufactured for the following application areas. When using the products covered herein for the equipment listed in Paragraph (2), even for the following application areas, be sure to observe the precautions given in Paragraph (2). Never use the products for the equipment listed in Paragraph (3).

- ·Office electronics
- ·Instrumentation and measuring equipment
- ·Machine tools
- ·Audiovisual equipment
- ·Home appliances
- ·Communication equipment other than for trunk lines

(2) Those contemplating using the products covered herein for the following equipment which demands high reliability, should first contact a sales representative of the company and then accept responsibility for incorporating into the design fail-safe operation, redundancy, and other appropriate measures for ensuring reliability and safety of the equipment and the overall system.

- ·Control and safety devices for airplanes, trains, automobiles, and other transportation equipment
- ·Mainframe computers
- ·Traffic control systems
- ·Gas leak detectors and automatic cutoff devices
- ·Rescue and security equipment
- ·Other safety devices and safety equipment, etc.

(3) Do not use the products covered herein for the following equipment which demands extremely high performance in terms of functionality, reliability, or accuracy.

- ·Aerospace equipment
- ·Communications equipment for trunk lines
- ·Control equipment for the nuclear power industry
- ·Medical equipment related to life support, etc.

(4) Please direct all queries and comments regarding the interpretation of the above three Paragraphs to a sales representative of the company.

●Please direct all queries regarding the products covered herein to a sales representative of the company.

Contents

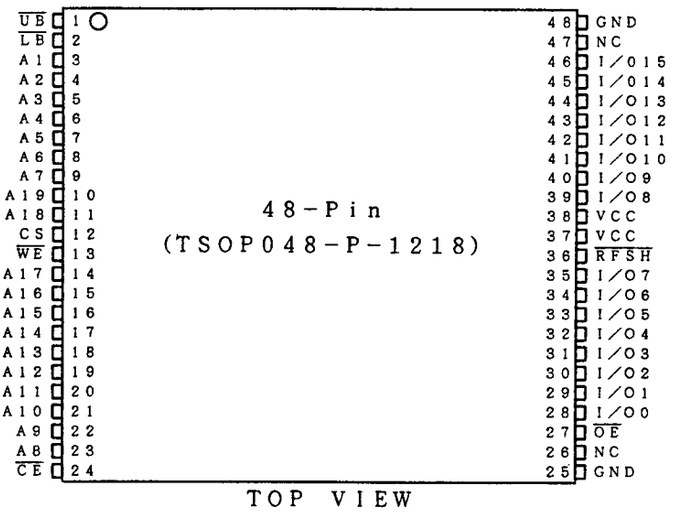
1. General

The LH6P82Z1 is a 8M bit PSEUDO-SRAM with a 524,288-word by 16-bit configuration. $\overline{RFSH}$ pin and $\overline{OE}$ pin can be connected and used like a $\overline{OE}/\overline{RFSH}$ pin of standard 4M bit PSEUDO-SRAM, so it is easy to replace the 4M bit PSEUDO SRAMs with the LH6P82Z1.

2. Features

- 524,288 x 16 bit organization
- Power supply
  - Operating: +3.3±0.3V
  - Data retention: +2.2V to +3.6V
- Access time: 120ns (MAX.)
- Cycle time: 190ns (MIN.)
- Power consumption
  - Operating: 144mW (MAX.)
  - Standby: 180μW (MAX.)(CMOS input level)
  - Self-refresh: 360μW (MAX.)(Vcc=3.0V, CMOS input level)
- LVTTL compatible I/O
- Available for address refresh, auto-refresh and self-refresh modes
- 4,096 refresh cycles/64ms
- Address non-multiplex
- Package: 48-pin, TSOP(I) (TSOP48-P-1218)
- Package material: Plastic
- Substrate material: P-type silicon
- Process: Silicon-gate CMOS
- Operating Temperature: 0 to 70 °C
- Not designed or rated as radiation hardened

3. Pin Configuration and Pin Description



TOP VIEW

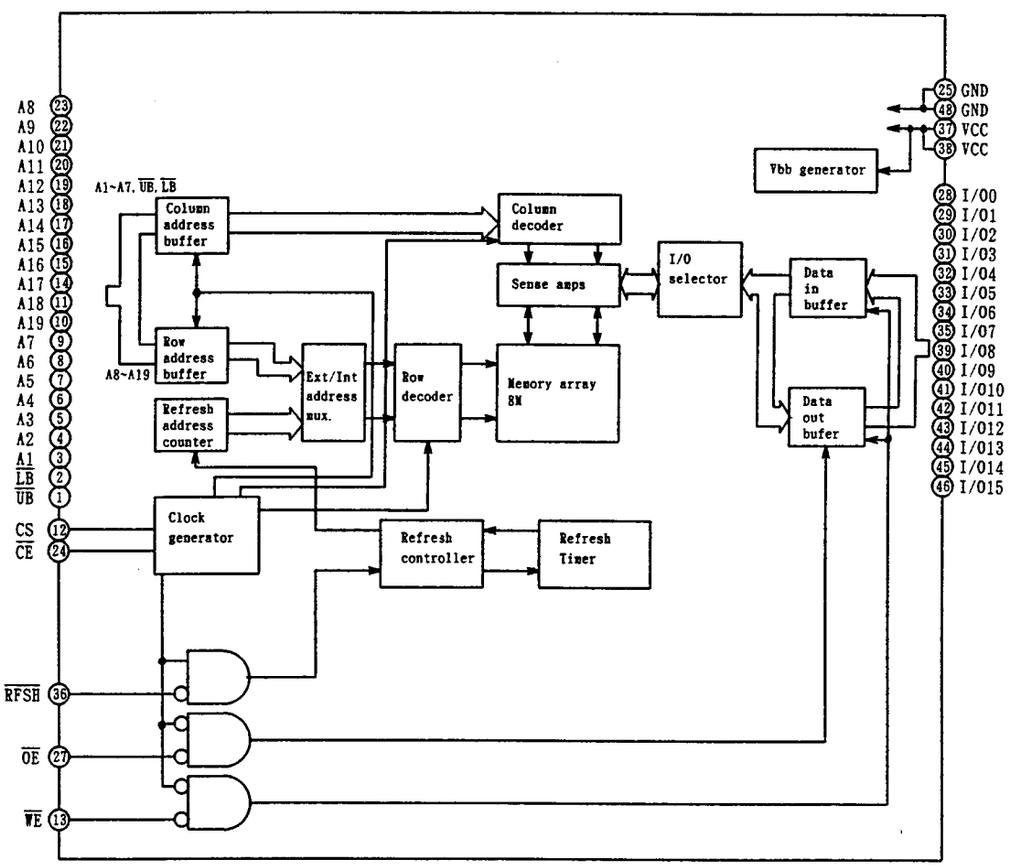
Signal	Pin Name
A_8-A_{19}	Row address input
A_1-A_7	Column address input
$\overline{UB}$, $\overline{LB}$	Upper/Lower byte select input
$\overline{RFSH}$	Refresh input
$\overline{OE}$	Output enable input
$\overline{WE}$	Write enable input
$\overline{CE}$	Chip enable input
CS	Chip select input
I/O_8-I/O_{15}	Upper byte data input/output
I/O_0-I/O_7	Lower byte data input/output
Vcc	Power supply
GND	Ground

$\overline{CE}$	CS	$\overline{RFSH}$	$\overline{WE}$	$\overline{OE}$	$\overline{UB}$	$\overline{LB}$	Mode		I/O 0~7	I/O 8~15
L	H	H Note 1	H	L	H	L	Read	Lower byte access	Output data	High-Z
					L	H		Upper byte access	High-Z	Output data
					L	L		Word access	Output data	Output data
					H	H		Invalid	High-Z	High-Z
L	H	H Note 1	L	X	H	L	Write	Lowe byte access	Input data	High-Z
					L	H		Upper byte access	High-Z	Input data
					L	L		Word access	Input data	Input data
					H	H		Invalid	High-Z	High-Z
H	X	L	X	X	X	X	Auto Refresh		High-Z	High-Z
L	L	H	X	X	X	X	CS Standby		High-Z	High-Z
H	X	H	X	X	X	X	Standby		High-Z	High-Z

H=High, L=Low, X=Don't Care

Note 1:If $\overline{RFSH}$=L, it is necessary to meet t_{RDH} when $\overline{RFSH}$ falling.

4. Block Diagram



5. Absolute Maximum Ratings

Parameter	symbol	Rating	Unit	Note
Supply voltage	V_T	-0.5 to +4.6	V	2
Output short circuit current	I_O	50	mA	
Power dissipation	P_D	600	mW	
Operating temperature	T_{opr}	0 to +70	℃	
Storage temperature	T_{stg}	-65 to +150	℃	

Note 2: The maximum applicable voltage on any pin with respect to GND.

6. Recommended Operating Conditions

(Ta = 0 to 70℃)

Parameter	Symbol	MIN.	TYP.	MAX.	Unit	Note
Supply voltage	Vcc	3.0		3.6	V	3
	GND	0	0	0	V	3
Input voltage	V_{IH}	2.0		4.5	V	
	V_{IL}	-0.5		0.8	V	

Note 3: The supply voltage with all Vcc pins must be on the same level.
The supply voltage with all GND pins must be on the same level.

7. Pin Capacitance

(Ta = 25℃, f = 1MHz, Vcc = 3.3V)

Parameter		Symbol	MIN.	MAX.	Unit
Input capacitance	A_1-A_{19}, $\overline{UB}$, $\overline{LB}$	C_{IN1}		8	pF
	$\overline{WE}$, $\overline{OE}$	C_{IN2}		8	pF
	$\overline{CE}$, CS, $\overline{RFSH}$	C_{IN3}		8	pF
Input/Output capacitance	I/O_0-I/O_{15}	C_{OUT1}		10	pF

8. DC Electrical Characteristics

(Ta = 0 to 70℃, Vcc = 3.0V to 3.6V)

Parameter	Symbol	Condition	MIN.	MAX.	Unit	Note
Operating current in normal operation	I_{CC1}	$t_{RC}=t_{RC}$(MIN.)	-	40	mA	4,5
Standby current	I_{CC2}	$\overline{CE}$, $\overline{RFSH}=V_{IH}$(MIN.)	-	1	mA	4
		$\overline{CE}$, $\overline{RFSH}=V_{CC}-0.2V$	-	50	μA	4
Self-refresh average current	I_{CC3}	$\overline{CE}=V_{IH}$(MIN.), $\overline{RFSH}=V_{IL}$(MAX.), Vcc=3.0V	-	1	mA	4
		$\overline{CE}=V_{CC}-0.2V$, $\overline{RFSH}=0.2V$, Vcc=3.0V	-	120	μA	4
Input leakage current	I_{LI}	$0V \leq V_{IN} \leq 6.5V$, 0V on all other pins	-10	10	μA	
Output leakage current	I_{LO}	$0V \leq V_{OUT} \leq Vcc+0.3V$, Input/output pins in High-Z state	-10	10	μA	
Output High voltage	V_{OH}	$I_{OUT}=-1mA$	2.4	-	V	
		$I_{OUT}=-100\mu A$	$V_{CC}-0.2$	-		
Output Low voltage	V_{OL}	$I_{OUT}=1mA$	-	0.4	V	
		$I_{OUT}=100\mu A$	-	0.2		
Data retention voltage	V_R		2.2	3.6	V	

Note 4: The input/output pins are in high impedance state.

Note 5: I_{CC1} depends on the cycle time.

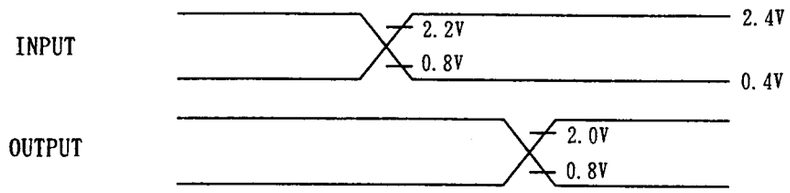
9. AC Electrical Characteristics(Note. 6, 7, 12, 21)(Ta= 0 to 70℃, Vcc=3.0V to 3.6V)

Parameter	Symbol	MIN.	MAX.	Unit	Note
Random read, write cycle time	t_{RC}	190	-	ns	
Random read modify write cycle time	t_{RMW}	250	-	ns	
$\overline{CE}$ pulse width	t_{CE}	120	10,000	ns	
$\overline{CE}$ precharge time	t_{P}	60	-	ns	
Address setup time	t_{AS}	0	-	ns	8
Row address hold time from $\overline{CE}$	t_{RAH}	30	-	ns	8
Column address hold time from $\overline{CE}$	t_{CAH}	120	-	ns	
CS setup time from $\overline{CE}$	t_{CSS}	0	-	ns	
CS hold time from $\overline{CE}$	t_{CSH}	30	-	ns	
Read command setup time	t_{RCS}	0	-	ns	
Read command hold time	t_{RCH}	0	-	ns	
$\overline{CE}$ Access time	t_{CEA}	-	120	ns	9
$\overline{OE}$ Access time	t_{OEA}	-	60	ns	9
$\overline{CE}$ to output in Low-Z	t_{CLZ}	20	-	ns	
$\overline{OE}$ to output in Low-Z	t_{OLZ}	0	-	ns	
Write disable to output in Low-Z	t_{WLZ}	0	-	ns	
Chip disable to output in High-Z	t_{CHZ}	0	30	ns	
Output disable to output in High-Z	t_{OHZ}	0	30	ns	
$\overline{WE}$ to output in High-Z	t_{WHZ}	0	30	ns	
Write command pulse width	t_{WCP}	35	-	ns	
Write command setup time	t_{WCS}	35	10,000	ns	
Write command hold time	t_{WCH}	120	10,000	ns	
Data setup time from write disable	t_{DSW}	30	-	ns	10
Data setup time from chip disable	t_{DSC}	30	-	ns	10
Data hold time from write disable	t_{DHW}	0	-	ns	10
Data hold time from chip disable	t_{DHC}	30	-	ns	10
Data hold time from column address	t_{OH}	0	-	ns	
Column address hold time from chip disable	t_{AHC}	0	-	ns	10
Column address hold time from write disable	t_{AHW}	0	-	ns	10

Parameter	Symbol	MIN.	MAX.	Unit	Note
Transition time (rise and fall)	t_T	3	50	ns	
Output disable setup time	t_{ODS}	0	-	ns	
Output disable hold time	t_{ODH}	15	-	ns	
Refresh time interval (4096 cycles)	t_{REF}	-	64	ms	11
Auto refresh cycle time	t_{FC}	190	-	ns	11
Refresh delay time from $\overline{CE}$	t_{RFD}	90	-	ns	
Refresh pulse width (Auto refresh)	t_{FAP}	80	8,000	ns	13, 22
Refresh precharge time (Auto refresh)	t_{FP}	40	-	ns	
$\overline{CE}$ delay time from refresh enable (Auto refresh)	t_{FCE}	190	-	ns	
Refresh pulse width (Self refresh)	t_{FAS}	8	-	ms	13, 22
$\overline{CE}$ delay time from refresh precharge (Self refresh)	t_{FRS}	600	-	ns	14, 15 16
Vcc recovery time from data retention	t_R	5	-	ms	17
Refresh set up time	t_{FS}	0	-	ns	
Refresh disable hold time	t_{RDH}	15	-	ns	
Chip disable delay time from $\overline{RFSH}$	t_{RDD}	15	-	ns	

Note 6: AC characteristics are measured at t_T=5ns.

Note 7: AC characteristics are measured at the following condition.



Note 8: Row address signals are latched in the memory at the falling edge of $\overline{CE}$.

Note 9: Measured with a load equivalent to 50pF.

Note 10: Input data is latched in the memory at the earlier rising edge of $\overline{CE}$ and $\overline{WE}$. One of [t_{AHW}, t_{DSW}, t_{DHW}] and [t_{AHC}, t_{DSC}, t_{DHC}] needs to be satisfied, and the other is "Don't care".

Note 11: Address refresh or auto refresh is needed to be executed 4096 times within 64ms.

Note 12: In order to initialize the internal circuits, an initial pause of 500μs with $\overline{CE}$=$\overline{RFSH}$=V_{IH} is required after power-up, and followed by at least 8 dummy cycles.

Note 13: Auto refresh and self refresh are defined by $\overline{RFSH}$ pulse width during $\overline{CE}$=V_{IH}. If $\overline{RFSH}$ pulse width is shorter than t_{FAP}(MAX.), the cycle is an auto refresh cycle and memory cells are refreshed by an internal counter. If $\overline{RFSH}$ pulse width is longer than t_{FAS}(MIN.), the cycle is a self refresh cycle and memory cells are refreshed by an internal clock generator automatically.

Note 14: If address refresh is used during normal read/write cycles, the first address refresh must be executed within 15μs after self-refresh or data retention mode ends and the address refresh must be executed continuously for 4096 refresh cycles.

Note 15: If distributed auto-refresh is used during normal read/write cycles, the first auto-refresh must be executed within 15μs after self-refresh or data retention mode ends.

Note 16: If burst auto-refresh is used during normal read/write cycles, the first auto-refresh must be executed within 15μs after self-refresh or data retention mode ends, and the auto-refresh must be executed continuously for 4096 refresh cycles.

Note 17: The transition time of the supply voltage in data retention mode is less than 0.05V/ms.

Note 18: The data retention period must be longer than t_{FAS}(MIN.) like self-refresh cycle.

Note 19: $\overline{RFSH}$ must be lower than 0.2V during the data retention period.

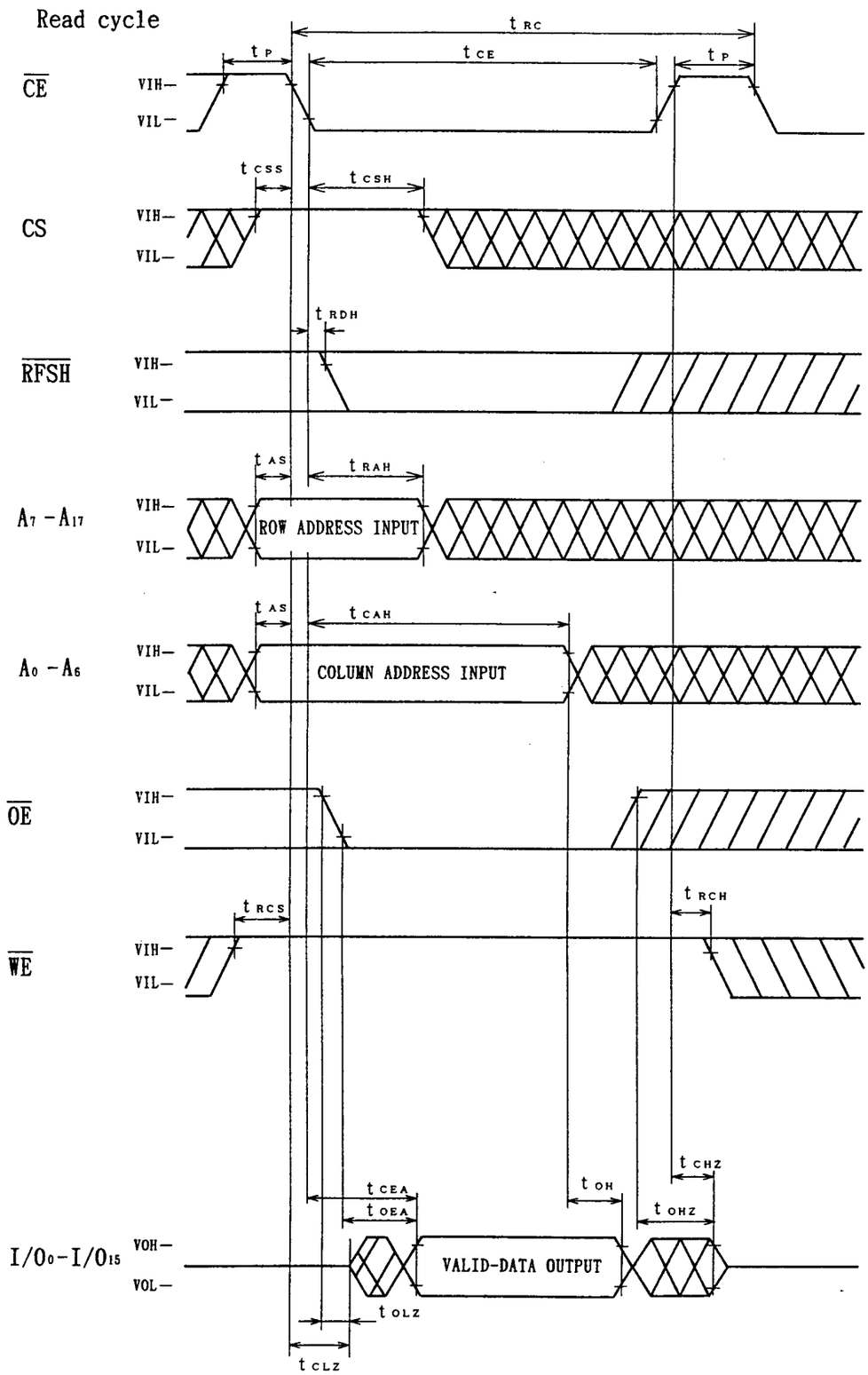
Note 20: $\overline{CE}$ and CS must be higher than Vcc-0.2V during the data retention period.

Note 21: Because a PSRAM operates dynamically like a DRAM, it is recommended to put bypass capacitors between Vcc and GND to absorb power supply noise due to the peak current.

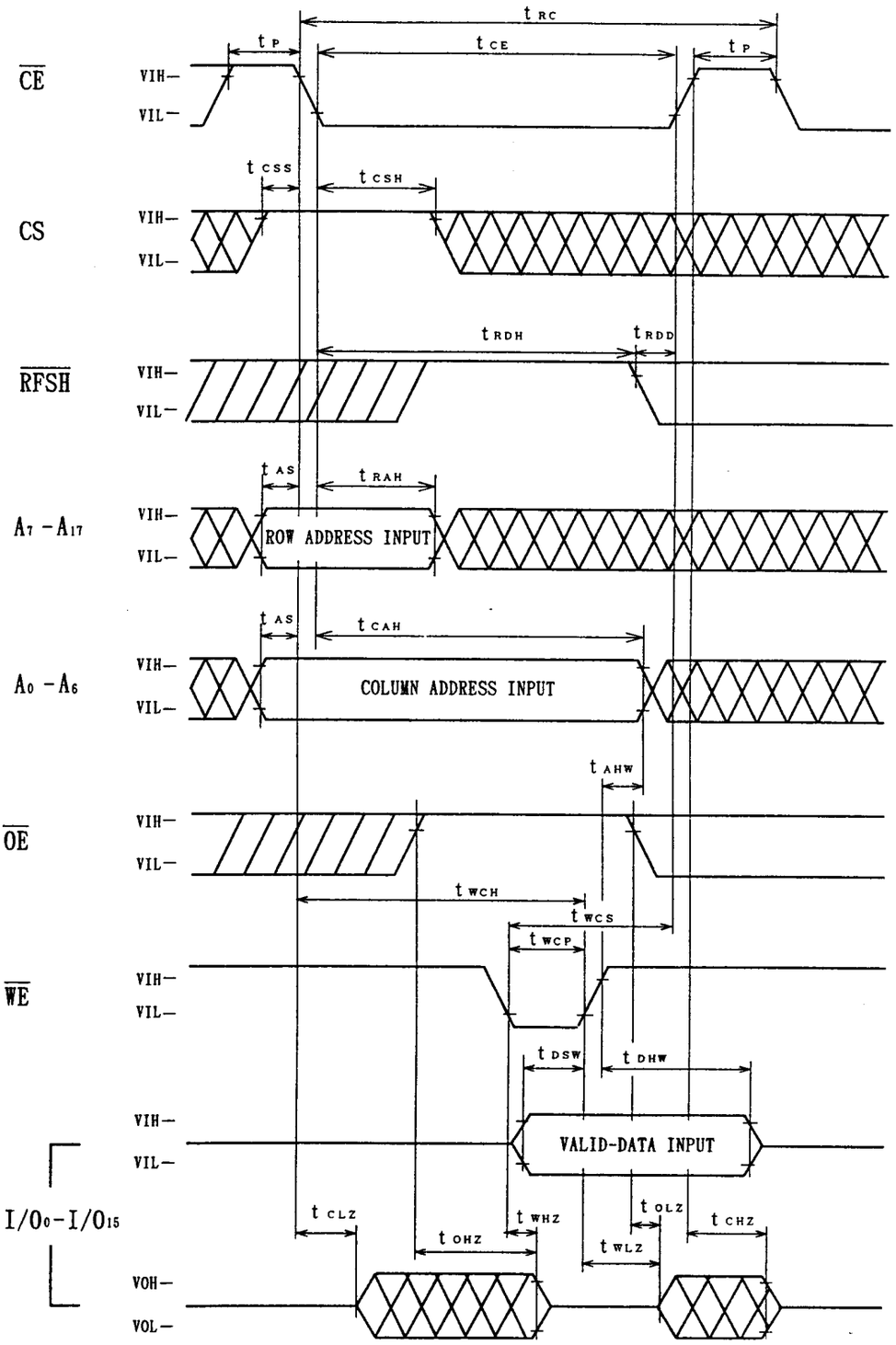
Note 22: After 8000ns(t_{FAP}(MAX.)) from $\overline{RFSH}$ falling, the memory resets its internal address counter and enters self-refresh cycle. At the beginning of the self-refresh cycle, it takes longer than 8ms for all addresses to be refreshed. Therefore, in case that the $\overline{RFSH}$=L pulse length is from 8000ns to 8ms, refresh all addresses by external clocks within 64ms before the self-refresh to keep refresh time interval(t_{REF}(MAX.)).

10. Timing Charts

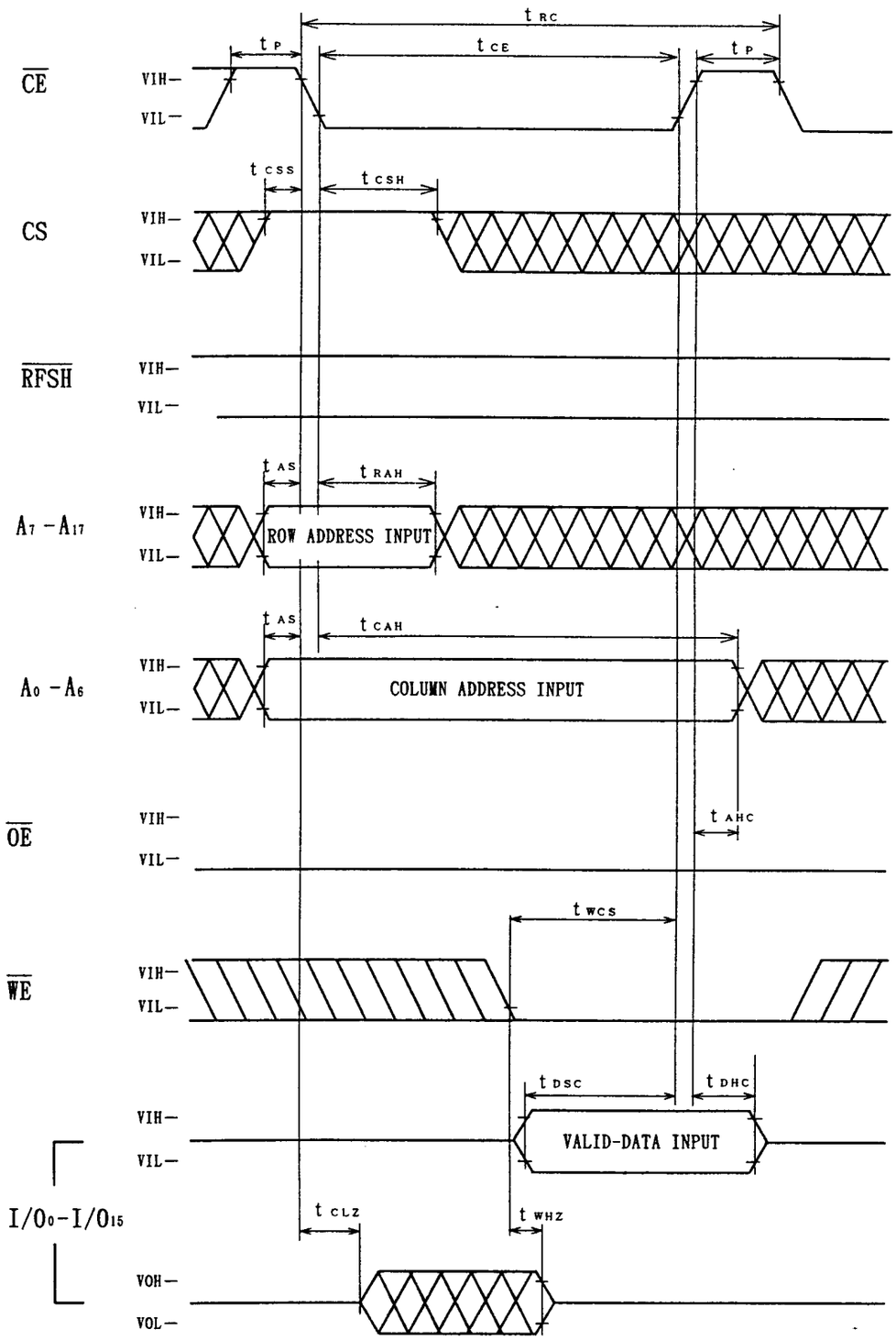
Read cycle



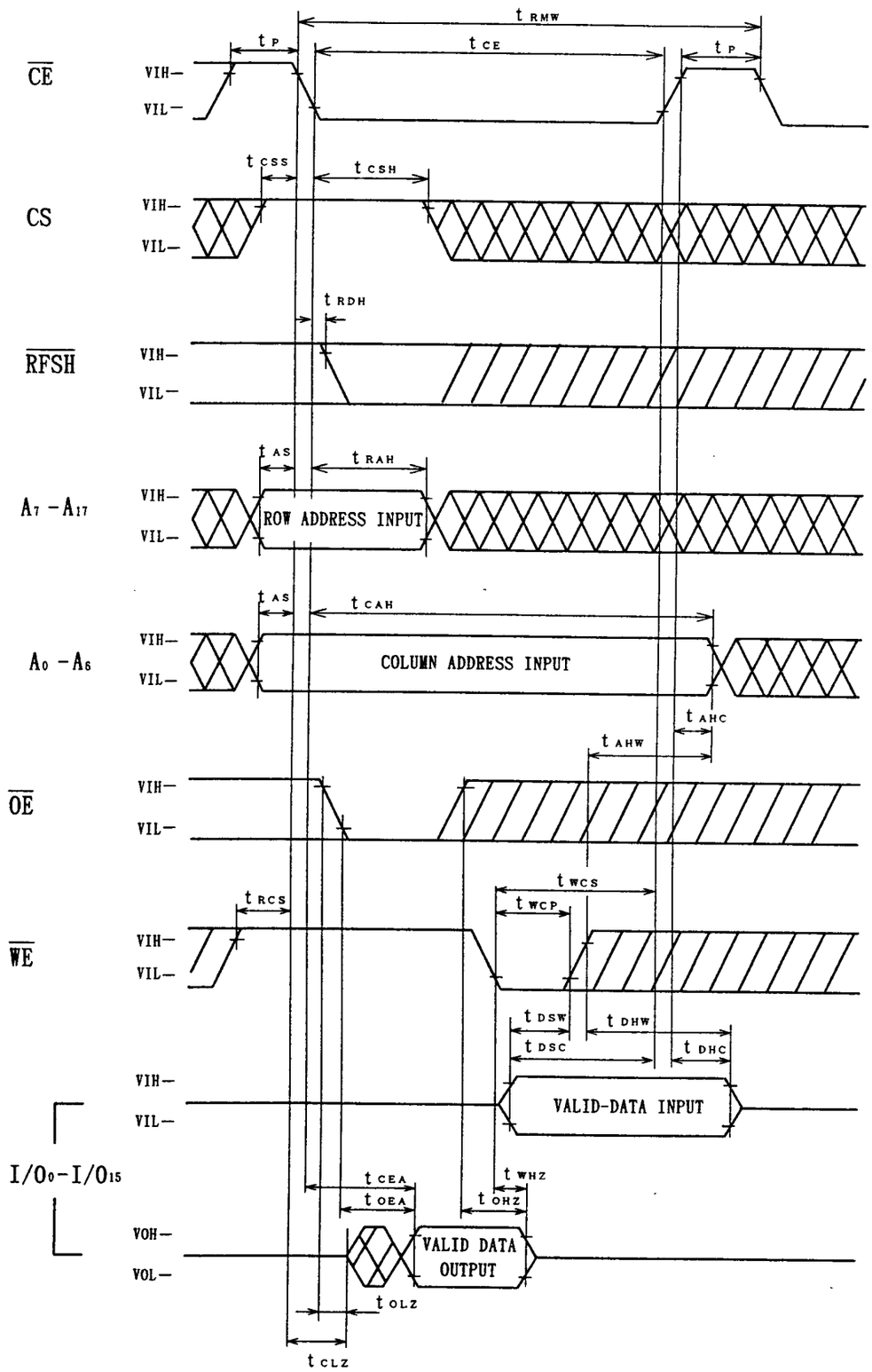
Write cycle(1) ($\overline{OE}$ Clock)



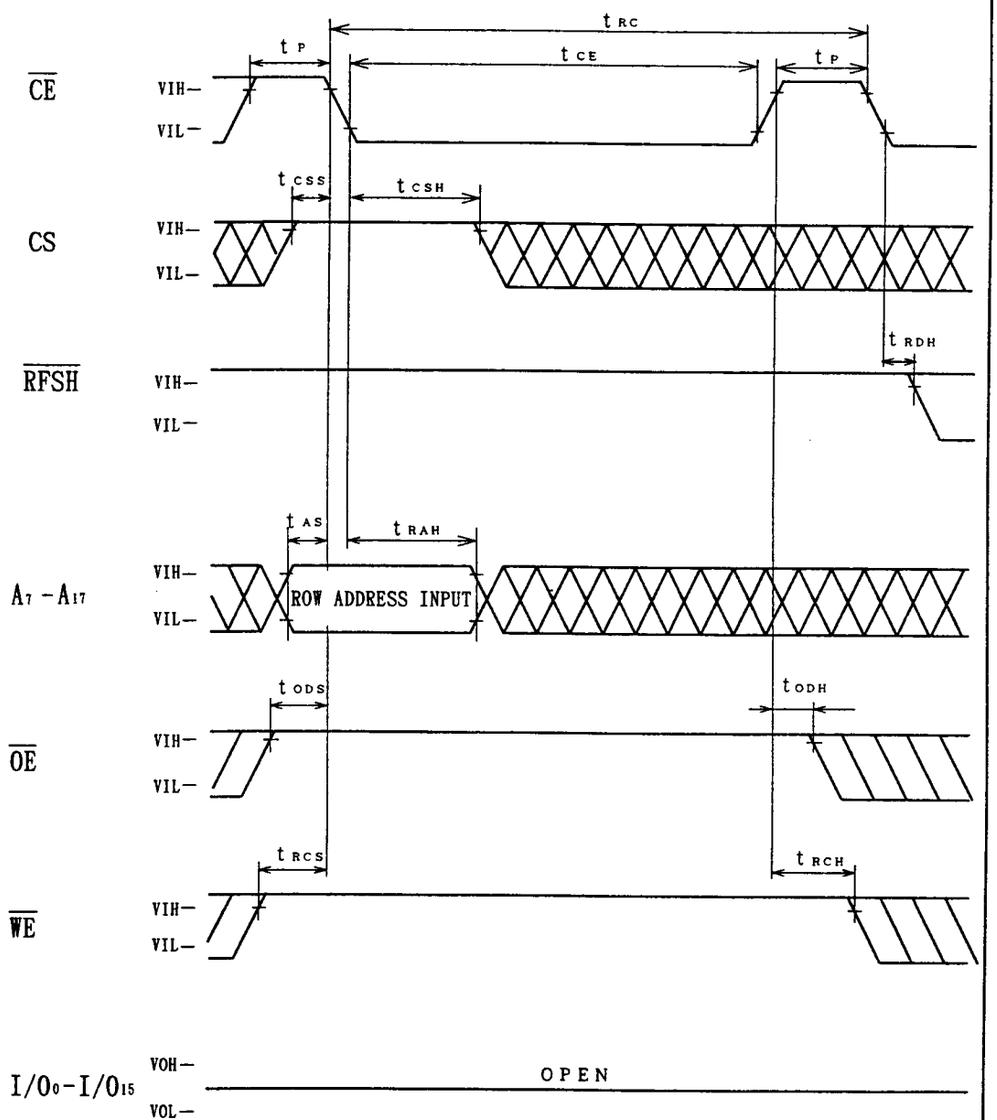
Write cycle(2) ($\overline{OE}$=Low, $\overline{CE}$ Control)



Read modify write cycle

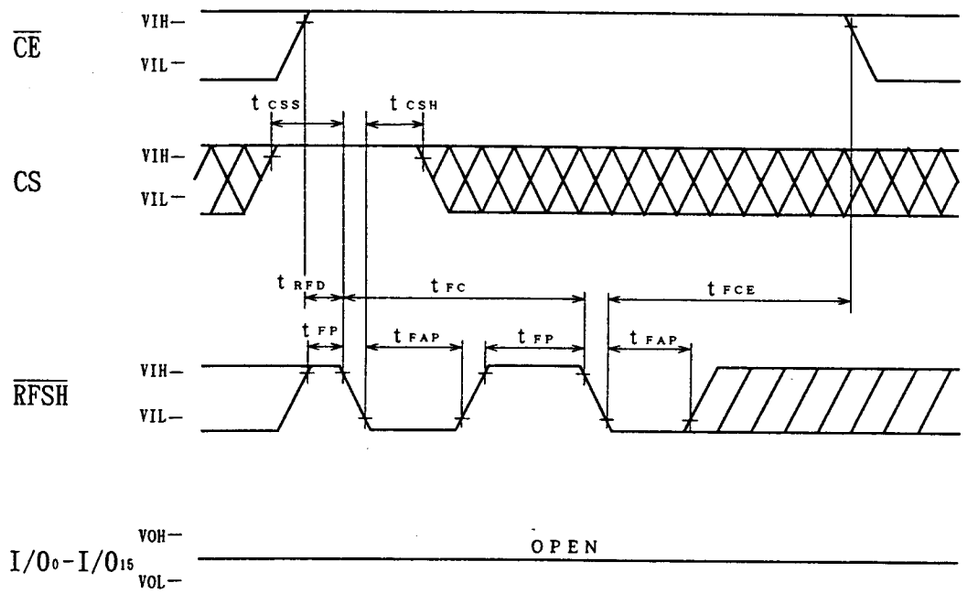


Address refresh cycle (Note. 10, 13)



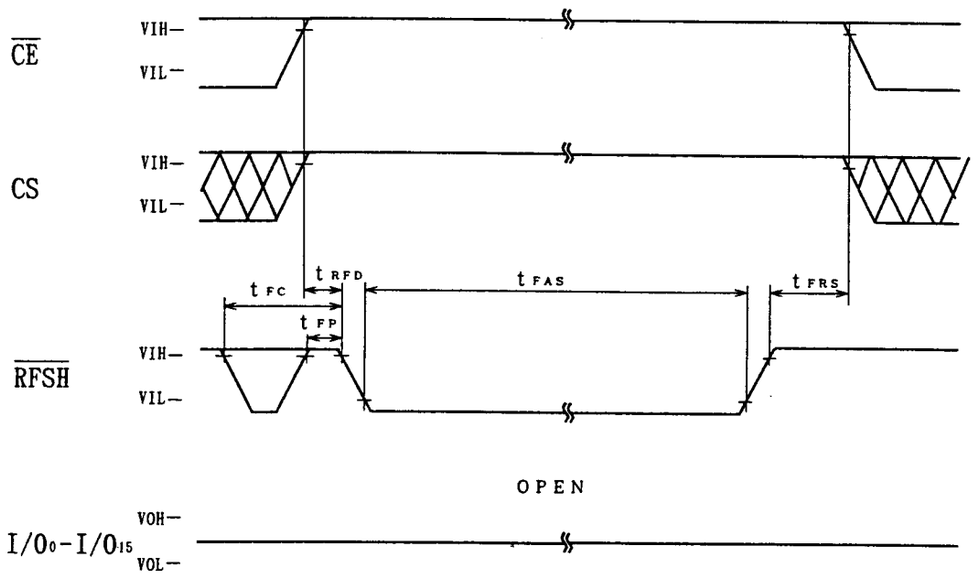
A_0 - A_7 , $\overline{UB}$ and $\overline{LB}$ =Don't Care

Auto refresh cycle (Note. 10, 12, 14, 15)



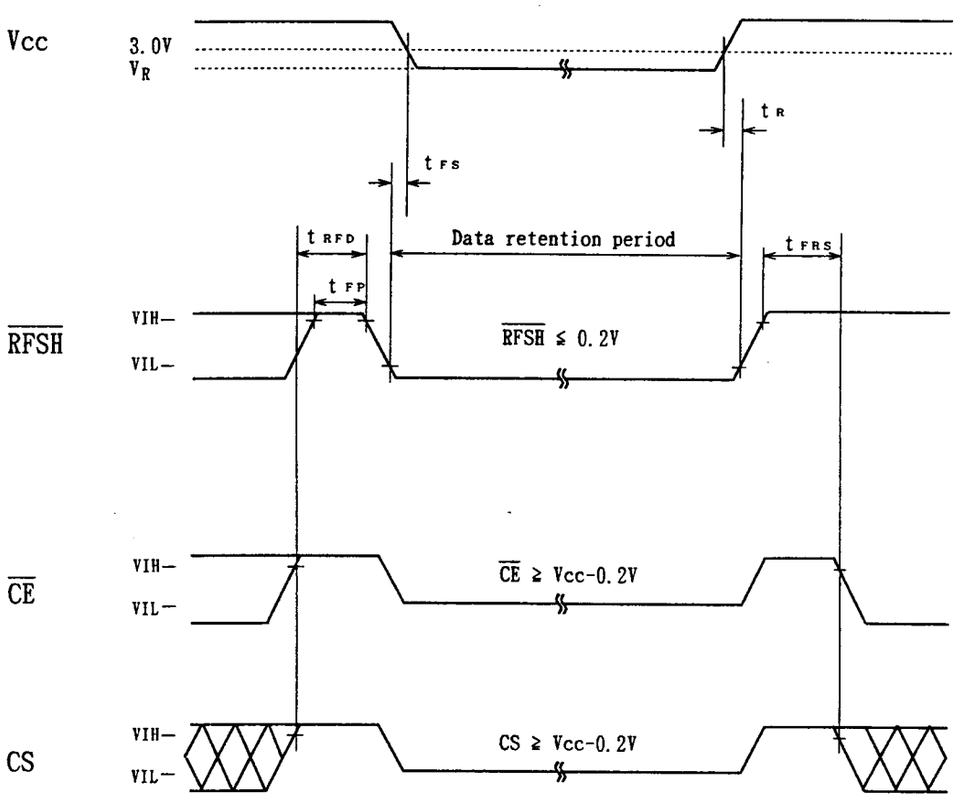
A_0 - A_{19}, $\overline{UB}$, $\overline{LB}$, $\overline{WE}$ and $\overline{OE}$ =Don't Care

Self refresh cycle (Note. 13、14、15、16)



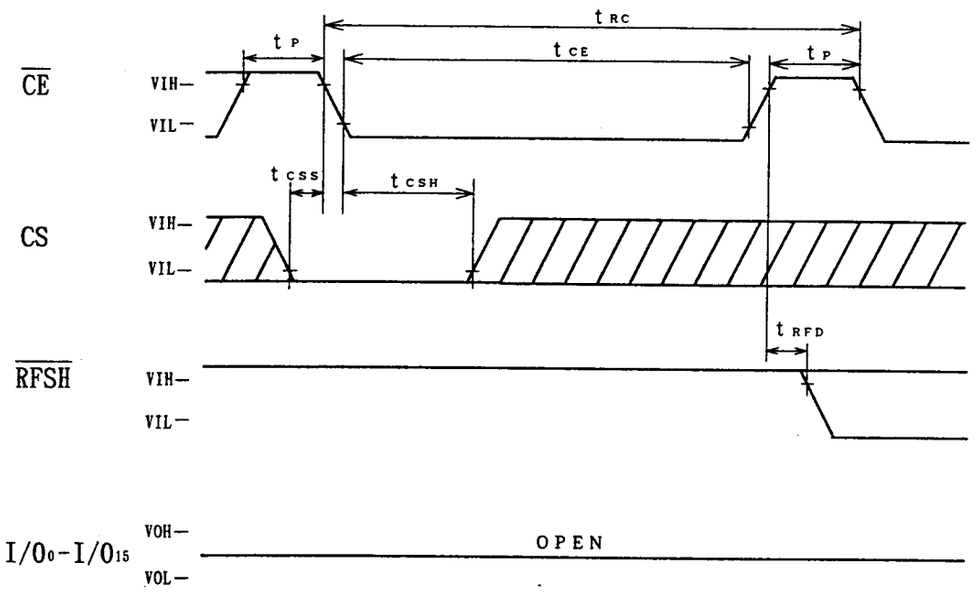
A_0 - A_{19}, $\overline{UB}$, $\overline{LB}$, $\overline{WE}$ and $\overline{OE}$ =Don't Care

Data Retention Mode (Note. 17, 18, 19, 20)



$A_0 - A_{19}$, $\overline{UB}$, $\overline{LB}$, $\overline{WE}$ and $\overline{OE}$ =Don't Care

CS Standby mode



A_0 - A_{19}, $\overline{UB}$, $\overline{LB}$, $\overline{WE}$ and $\overline{OE}$ =Don't Care

11 Package and packing specification

1. Package Outline Specification

Refer to drawing No.AA1046

2. Markings

2−1. Marking contents

(1) Product name : LH6P82T

(2) Company name : SHARP

(3) Date code

(Example) YY WW ×××

- YY → Denotes the production year. (Lower two digits of the year.)
- WW → Denotes the production week. (01,02,03,・・・・・52,53)
- ××× → Denotes the production ref.code (1~3)

Indicates the product was manufactured in the WWth week of 19YY.

(4) The marking of "JAPAN" indicates the country of origin.

2−2. Marking layout

Refer drawing No.AA1046

(This layout does not define the dimensions of marking character and marking position.)

3. Packing Specification (Dry packing for surface mount packages)

Dry packing is used for the purpose of maintaining IC quality after mounting packages on the PCB (Printed Circuit Board).

When the epoxy resin which is used for plastic packages is stored at high humidity, it may absorb 0.15% or more of its weight in moisture. If the surface mount type package for a relatively large chip absorbs a large amount of moisture between the epoxy resin and insert material (e.g. chip, lead frame) this moisture may suddenly vaporize into steam when the entire package is heated during the soldering process (e.g. VPS). This causes expansion and results in separation between the resin and insert material, and sometimes cracking of the package. This dry packing is designed to prevent the above problem from occurring in surface mount packages.

3−1. Packing Materials

Material Name	Material Specificaiton	Purpose
Tray	Conductive plastic (60devices/tray)	Fixing of device
Upper cover tray	Conductive plastic (1tray/case)	Fixing of device
Laminated aluminum bag	Aluminum polyethylene (1bag/case)	Drying of device
Desiccant	Silica gel	Drying of device
P P band	Polypropylene (3pcs/case)	Fixing of tray
Inner case	Card board (600device/case)	Packaging of device
Label	Paper	Indicates part number, quantity and date of manufacture
Outer case	Card board	Outer packing of tray

(Devices shall be placed into a tray in the same direction.)

3－2. Outline dimension of tray
Refer to attached drawing

4. Storage and Opening of Dry Packing

4－1. Store under conditions shown below before opening the dry packing
(1) Temperature range : 5～40℃
(2) Humidity : 80% RH or less

4－2. Notes on opening the dry packing
(1) Before opening the dry packing, prepare a working table which is grounded against ESD and use a grounding strap.
(2) The tray has been treated to be conductive or anti-static. If the device is transferred to another tray, use a equivalent tray.

4－3. Storage after opening the dry packing
Perform the following to prevent absorption of moisture after opening.
(1) After opening the dry packing, store the ICs in an environment with a temperature of 5～25℃ and a relative humidity of 60% or less and mount ICs within 72 hours after opening dry packing.

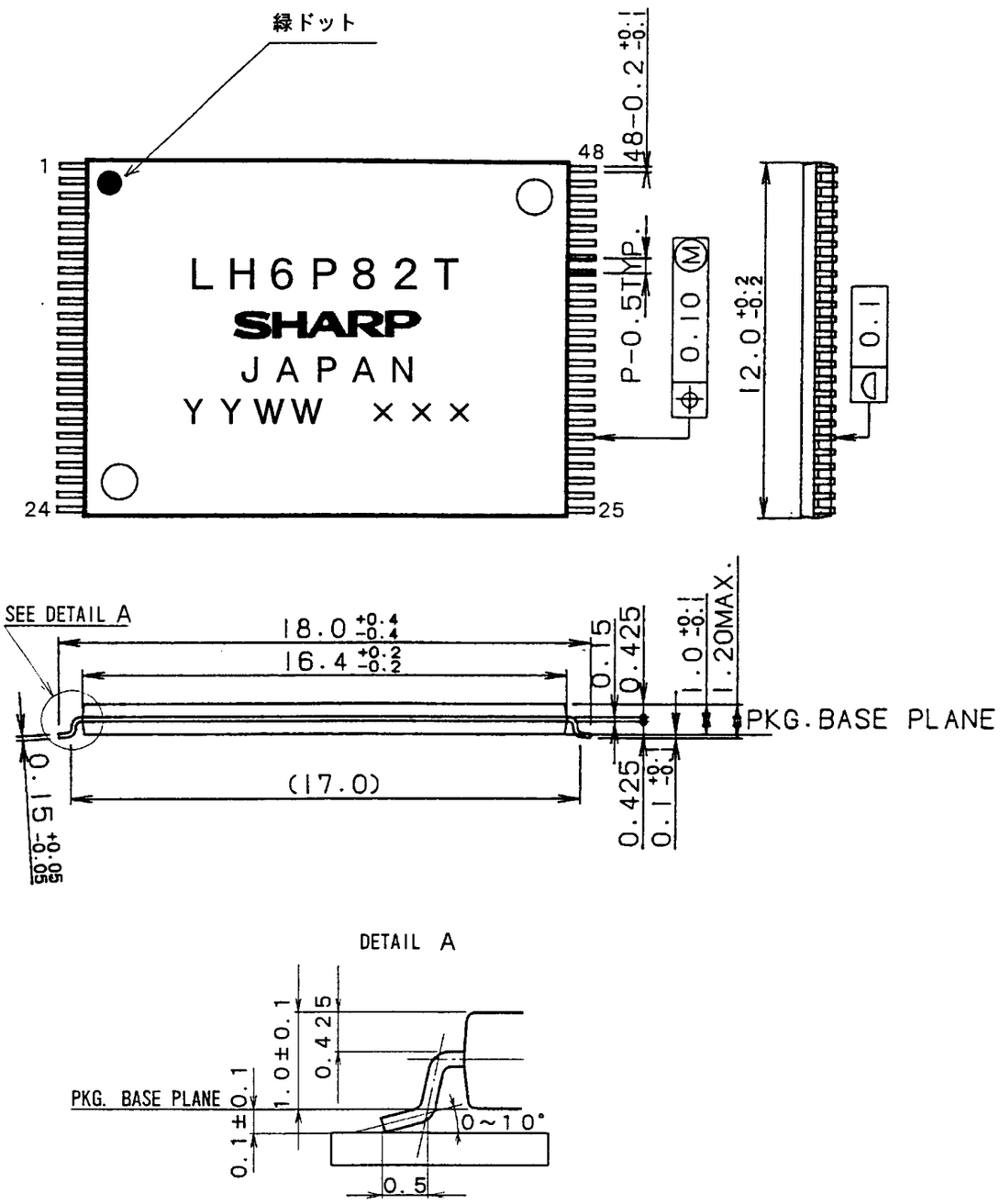
4－4. Baking (drying) before mounting
(1) Baking is necessary
(A) If the humidity indicator in the desiccant becomes pink
(B) If the procedure in section 4－3 could not be performed
(2) Recommended baking conditions
If the above conditions (A) and (B) are applicable, bake it before mounting. The recommended conditions are 16~24 hours at 120℃.
Heat resistance tray is used for shipping tray.

5. Surface Mount Conditions
Please perform the following conditions when mounting ICs not to deteriorate IC quality.

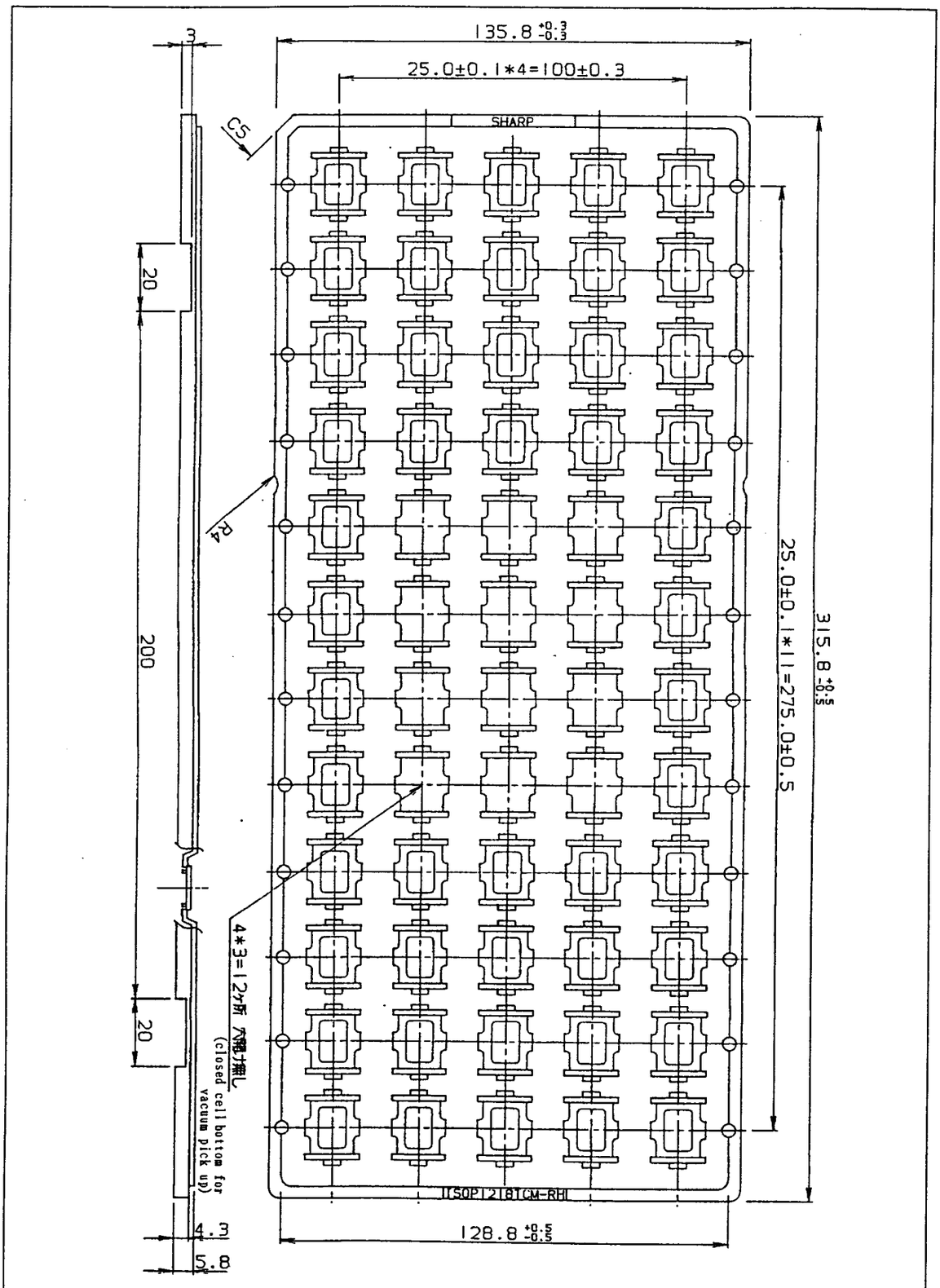
5－1.Soldering conditions(The following conditions are valid only for one time soldering.)

Mounting Method	Temperature and Duration	Measurement Point
Reflow soldering (air)	Peak temperature of 230℃ or less, duration of less than 15 seconds. 200℃ or over,duration of less than 40 seconds. Temperature increase rate of 1～4℃/second	IC package surface
Manual soldering (soldering iron)	260℃ or less, duration of less than 10 seconds.	IC outer lead surface

5－2. Conditions for removal of residual flux
(1) Ultrasonic washing power : 25 Watts/liter or less
(2) Washing time : Total 1 minute maximum
(3) Solvent temperature : 15～40℃



名称 NAME	TSOP48-P-1218	リード仕上 LEAD FINISH	TIN-LEAD PLATING	備考 NOTE	プラスチックパッケージ外形寸法は、バリを含まないものとする。 Plastic body dimensions do not include burr of resin.
DRAWING NO.	AA1046	単位 UNIT	mm		



名称 NAME	TSOP1218TCM-RH			備考 NOTE
DRAWING NO.	CV537	単位 UNIT	mm	

PSRAM Low Voltage Low Power LH6P82Z1 8M (524Kx16) (120 ns) (TSOP)